Search Notes

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Application Control No.	<b>Application</b>	/Control	No.
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09/784,254 Examiner

Ellen C. Tran

Applicant(s)/Patent under Reexamination

FURUYA ET AL.

Art Unit

2134

SEARCHED			
Class	Subclass	Date	Examiner
713	193	3/16/2006	ECT
380	210	3/16/2006	ECT
380	259	3/16/2006	ECT
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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Interferen	ce Search	3/16/2007	ECT

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH, NPL	3/16/2006	ECT
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